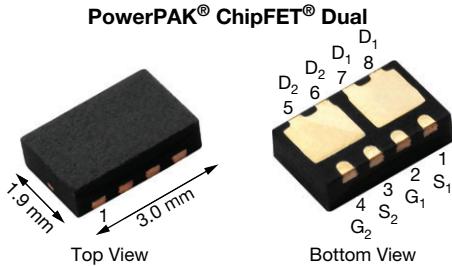


N- and P-Channel 20 V (D-S) MOSFET



Marking code: EA

PRODUCT SUMMARY		
	N-CHANNEL	P-CHANNEL
V _{DS} (V)	20	-20
R _{DS(on)} (Ω) at V _{GS} = ± 4.5 V	0.039	0.072
R _{DS(on)} (Ω) at V _{GS} = ± 2.5 V	0.045	0.100
R _{DS(on)} (Ω) at V _{GS} = ± 1.8 V	0.055	0.131
Q _g typ. (nC)	6	5.5
I _D (A) ^a	6	-6
Configuration	N- and p-pair	

FEATURES

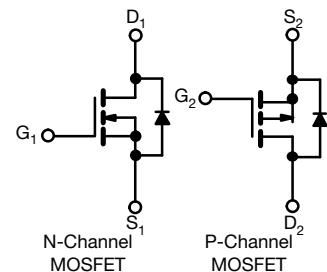
- TrenchFET® power MOSFETs
- Thermally enhanced PowerPAK ChipFET package
 - Small footprint area
 - Low on-resistance
 - Thin 0.8 mm profile
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



RoHS
COMPLIANT
HALOGEN
FREE

APPLICATIONS

- Complementary MOSFET for portable devices
 - Ideal for buck-boost circuits



ORDERING INFORMATION

Package	PowerPAK ChipFET
Lead (Pb)-free and halogen-free	Si5517DU-T1-GE3

ABSOLUTE MAXIMUM RATINGS (T_A = 25 °C, unless otherwise noted)

PARAMETER	SYMBOL	N-CHANNEL		P-CHANNEL		UNIT
		TYP.	MAX.	TYP.	MAX.	
Drain-source voltage	V _{DS}	20		-20		V
Gate-source voltage	V _{GS}	± 8		± 8		
Continuous drain current (T _J = 150 °C)	I _D	T _C = 25 °C	6 ^a	-6 ^a		A
		T _C = 70 °C	6 ^a	-6 ^a		
		T _A = 25 °C	7.2 b, c	-4.6 b, c		
		T _A = 70 °C	5.8 b, c	-3.7 b, c		
Pulsed drain current	I _{DM}	20		-15		
Source-drain current diode current	I _S	T _C = 25 °C	6.9	-6.9		
		T _A = 25 °C	1.9 b, c	-1.9 b, c		
Maximum power dissipation	P _D	T _C = 25 °C	8.3	8.3		W
		T _C = 70 °C	5.3	5.3		
		T _A = 25 °C	2.3 b, c	2.3 b, c		
		T _A = 70 °C	1.5 b, c	1.5 b, c		
Operating junction and storage temperature range	T _J , T _{stg}	-55 to +150				°C
Soldering recommendations (peak temperature) ^{d, e}		260				

THERMAL RESISTANCE RATINGS

PARAMETER	SYMBOL	N-CHANNEL		P-CHANNEL		UNIT
		TYP.	MAX.	TYP.	MAX.	
Maximum junction-to-ambient ^{b, f}	t ≤ 5 s	R _{thJA}	45	55	45	55
Maximum junction-to-case (drain)	Steady state	R _{thJC}	12	15	12	15

Notes

- Based on T_C = 25 °C
- Surface mounted on 1" x 1" FR4 board
- t = 5 s
- See solder profile (www.vishay.com/doc?73257). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components
- Maximum under steady state conditions is 105 °C/W for both channels

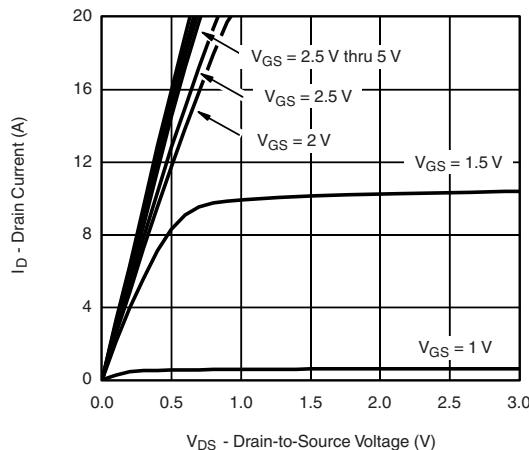
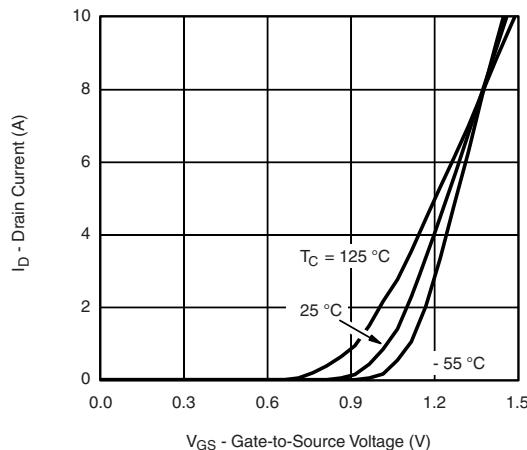
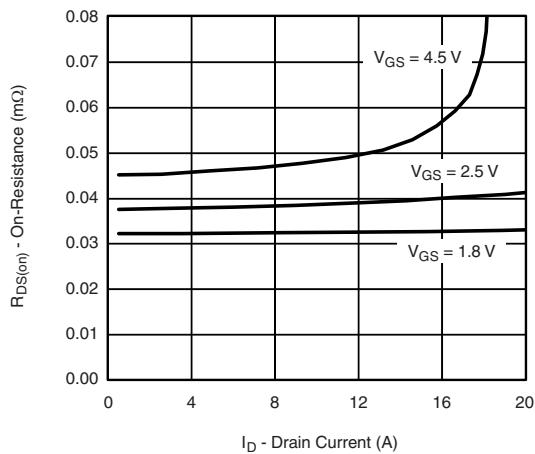
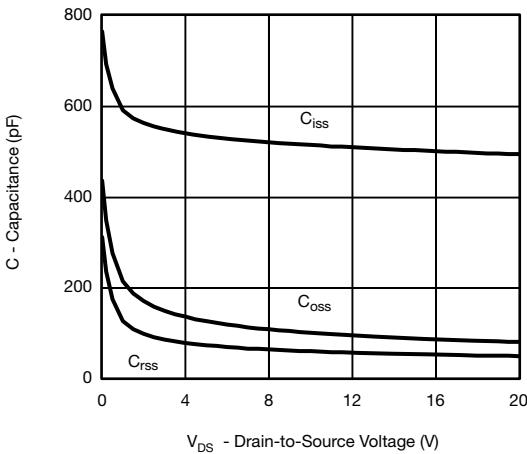
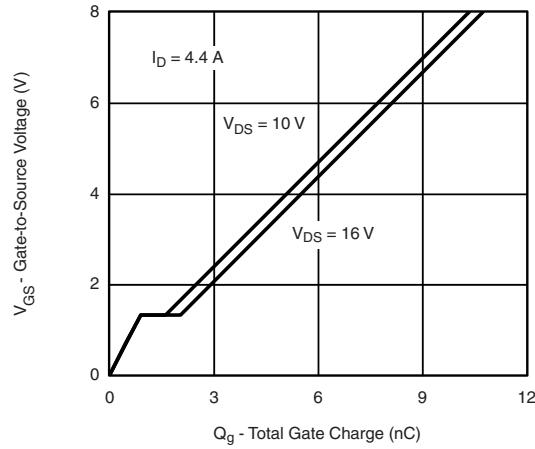
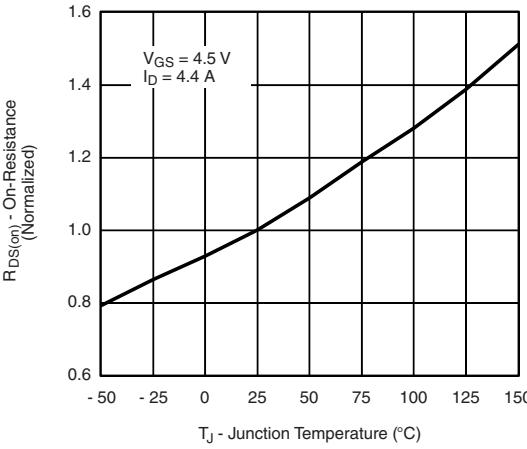
SPECIFICATIONS ($T_J = 25^\circ\text{C}$, unless otherwise noted)								
PARAMETER	SYMBOL	TEST CONDITIONS			MIN.	TYP. ^a	MAX.	UNIT
Static								
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}$, $I_D = 1 \text{ mA}$	N-Ch	20	-	-	V	
		$V_{GS} = 0 \text{ V}$, $I_D = -1 \text{ mA}$	P-Ch	-20	-	-		
V_{DS} temperature coefficient	$\Delta V_{DS}/T_J$	$I_D = 250 \mu\text{A}$	N-Ch	-	17	-	mV/°C	
		$I_D = -250 \mu\text{A}$	P-Ch	-	-20	-		
$V_{GS(\text{th})}$ temperature coefficient	$\Delta V_{GS(\text{th})}/T_J$	$I_D = 250 \mu\text{A}$	N-Ch	-	-2.6	-		
		$I_D = -250 \mu\text{A}$	P-Ch	-	2.4	-		
Gate-source threshold voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}$, $I_D = 250 \mu\text{A}$	N-Ch	0.4	-	1	V	
		$V_{DS} = V_{GS}$, $I_D = -250 \mu\text{A}$	P-Ch	-0.4	-	-1		
Gate-body leakage	I_{GSS}	$V_{DS} = 0 \text{ V}$, $V_{GS} = \pm 8 \text{ V}$	N-Ch	-	-	100	nA	
			P-Ch	-	-	-100		
Zero gate voltage drain current	I_{DSS}	$V_{DS} = 20 \text{ V}$, $V_{GS} = 0 \text{ V}$	N-Ch	-	-	1	μA	
		$V_{DS} = -20 \text{ V}$, $V_{GS} = 0 \text{ V}$	P-Ch	-	-	-1		
		$V_{DS} = 20 \text{ V}$, $V_{GS} = 0 \text{ V}$, $T_J = 55^\circ\text{C}$	N-Ch	-	-	10		
		$V_{DS} = -20 \text{ V}$, $V_{GS} = 0 \text{ V}$, $T_J = 55^\circ\text{C}$	P-Ch	-	-	-10		
On-state drain current ^b	$I_{D(on)}$	$V_{DS} \leq 5 \text{ V}$, $V_{GS} = 4.5 \text{ V}$	N-Ch	20	-	-	A	
		$V_{DS} \leq -5 \text{ V}$, $V_{GS} = -4.5 \text{ V}$	P-Ch	-15	-	-		
Drain-source on-state resistance ^b	$R_{DS(on)}$	$V_{GS} = 4.5 \text{ V}$, $I_D = 4.4 \text{ A}$	N-Ch	-	0.0320	0.0390	Ω	
		$V_{GS} = -4.5 \text{ V}$, $I_D = -3.3 \text{ A}$	P-Ch	-	0.0600	0.0720		
		$V_{GS} = 2.5 \text{ V}$, $I_D = 4.1 \text{ A}$	N-Ch	-	0.0370	0.0450		
		$V_{GS} = -2.5 \text{ V}$, $I_D = -2.8 \text{ A}$	P-Ch	-	0.0830	0.1000		
		$V_{GS} = 1.8 \text{ V}$, $I_D = 1.8 \text{ A}$	N-Ch	-	0.0455	0.0550		
		$V_{GS} = -1.8 \text{ V}$, $I_D = -0.76 \text{ A}$	P-Ch	-	0.1080	0.1310		
Forward transconductance ^b	g_{fs}	$V_{DS} = 10 \text{ V}$, $I_D = 4.4 \text{ A}$	N-Ch	-	22	-	S	
		$V_{DS} = -10 \text{ V}$, $I_D = -3.3 \text{ A}$	P-Ch	-	0.9	-		
Dynamic ^a								
Input capacitance	C_{iss}	N-channel $V_{DS} = 10 \text{ V}$, $V_{GS} = 0 \text{ V}$, $f = 1 \text{ MHz}$	N-Ch	-	520	-	pF	
Output capacitance	C_{oss}		P-Ch	-	455	-		
Reverse transfer capacitance	C_{rss}		N-Ch	-	100	-		
Total gate charge	Q_g		P-Ch	-	105	-		
Gate-source charge	Q_{gs}	P-channel $V_{DS} = -10 \text{ V}$, $V_{GS} = -4.5 \text{ V}$, $I_D = -1.8 \text{ A}$	N-Ch	-	60	-	nC	
Gate-drain charge	Q_{gd}		P-Ch	-	65	-		
Gate resistance	R_g		N-Ch	-	1.9	-	Ω	
			P-Ch	-	8	-		

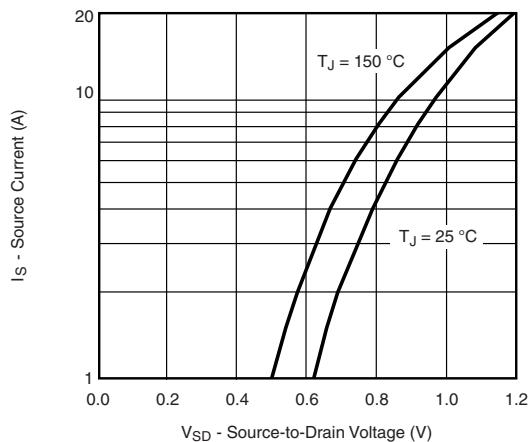
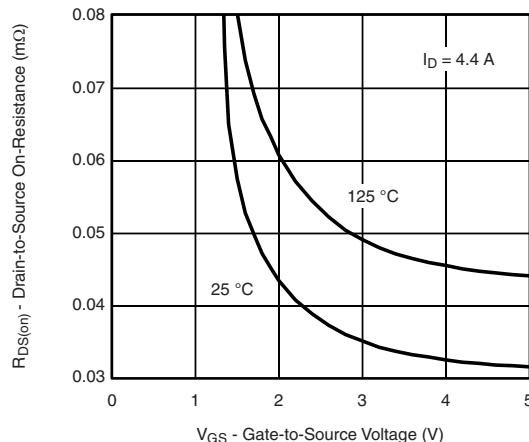
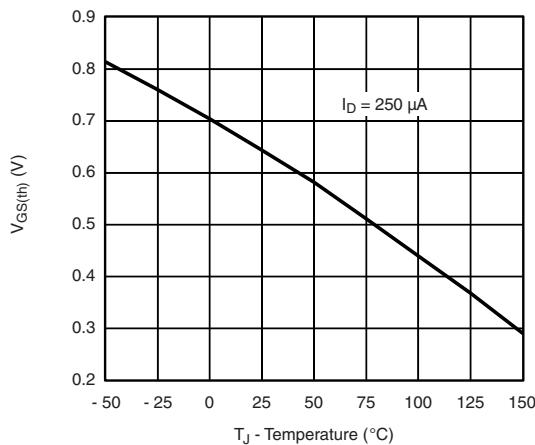
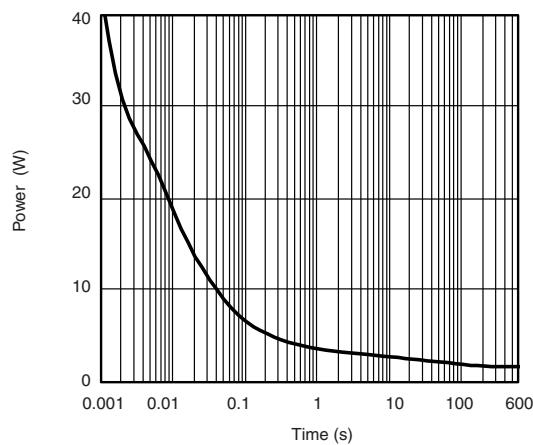
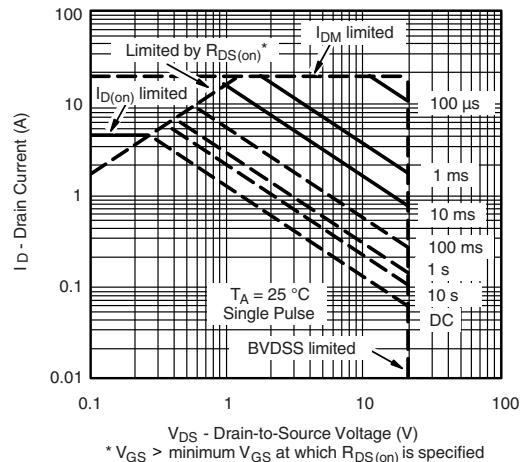
SPECIFICATIONS ($T_J = 25^\circ\text{C}$, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP. ^a	MAX.	UNIT
Dynamic ^a							
Turn-on delay time	$t_{d(on)}$	N-channel $V_{DD} = 10 \text{ V}$, $R_L = 2.8 \Omega$, $I_D \geq 3.6 \text{ A}$, $V_{GEN} = 4.5 \text{ V}$, $R_g = 1 \Omega$ P-channel $V_{DD} = -10 \text{ V}$, $R_L = 2.7 \Omega$, $I_D \leq -3.7 \text{ A}$, $V_{GEN} = -4.5 \text{ V}$, $R_g = 1 \Omega$	N-Ch	-	20	30	
Rise time	t_r		P-Ch	-	8	15	
Turn-off delay time	$t_{d(off)}$		N-Ch	-	65	100	
Fall time	t_f		P-Ch	-	35	55	
Turn-on delay time	$t_{d(on)}$		N-Ch	-	40	60	
Rise time	t_r		P-Ch	-	40	60	
Turn-off delay time	$t_{d(off)}$		N-Ch	-	10	15	
Fall Time	t_f		P-Ch	-	55	85	
Turn-on delay time	$t_{d(on)}$		N-Ch	-	5	10	
Rise time	t_r		P-Ch	-	5	10	
Drain-Source Body Diode Characteristics							
Continuous source-drain diode current	I_S	$T_C = 25^\circ\text{C}$	N-Ch	-	-	6.9	A
Pulse diode forward current ^a	I_{SM}		P-Ch	-	-	-6.9	
Body diode voltage	V_{SD}	$I_S = 1.2 \text{ A}$, $V_{GS} = 0 \text{ V}$	N-Ch	-	0.8	1.2	V
		$I_S = -1.0 \text{ A}$, $V_{GS} = 0 \text{ V}$	P-Ch	-	-0.8	-1.2	
Body diode reverse recovery time	t_{rr}	N-channel $I_F = 1.2 \text{ A}$, $\text{di}/\text{dt} = 100 \text{ A}/\mu\text{s}$, $T_J = 25^\circ\text{C}$ P-channel $I_F = -1 \text{ A}$, $\text{di}/\text{dt} = -100 \text{ A}/\mu\text{s}$, $T_J = 25^\circ\text{C}$	N-Ch	-	45	70	ns
Body diode reverse recovery charge	Q_{rr}		P-Ch	-	30	60	
Reverse recovery fall time	t_a		N-Ch	-	21	32	nC
Reverse recovery rise time	t_b		P-Ch	-	15	30	
			N-Ch	-	29	-	ns
			P-Ch	-	11	-	
			N-Ch	-	16	-	ns
			P-Ch	-	19	-	

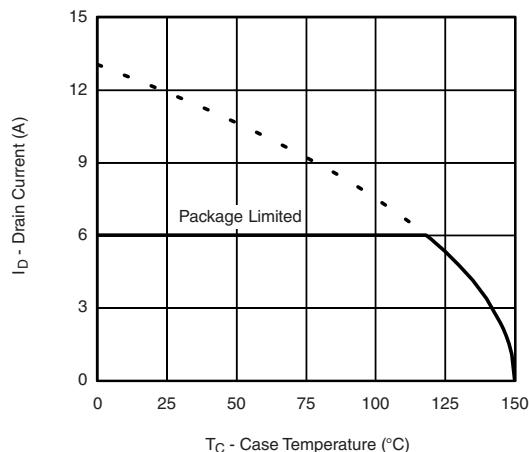
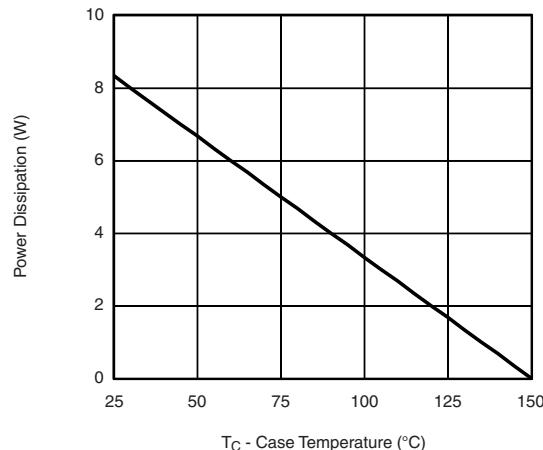
Notes

- a. Guaranteed by design, not subject to production testing
- b. Pulse test; pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2 \%$

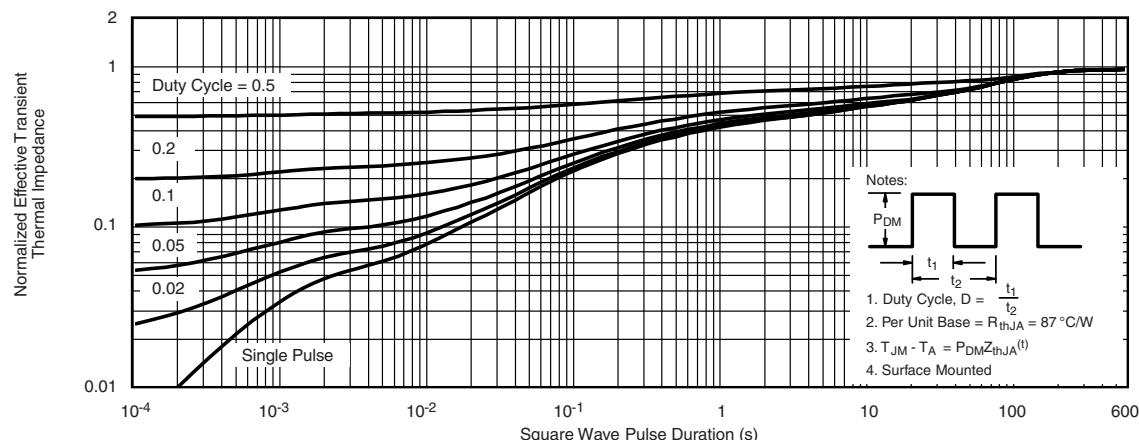
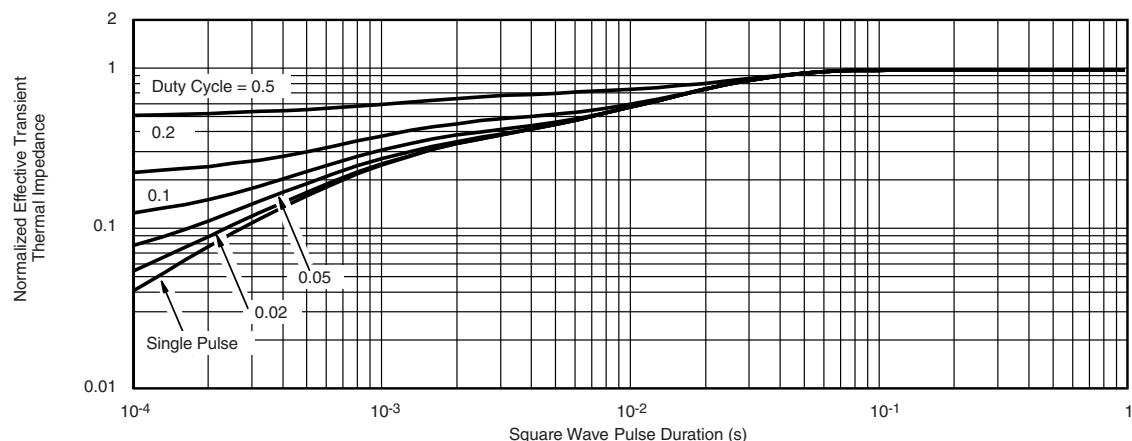
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

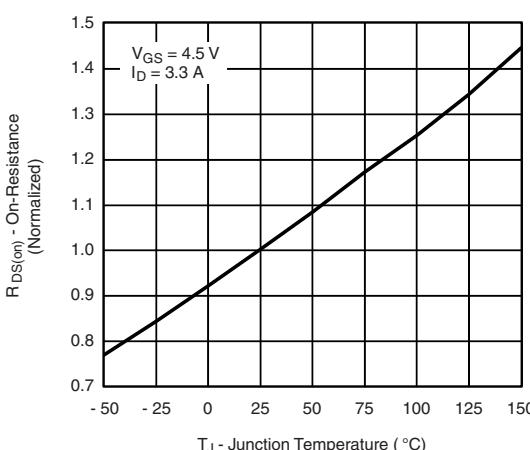
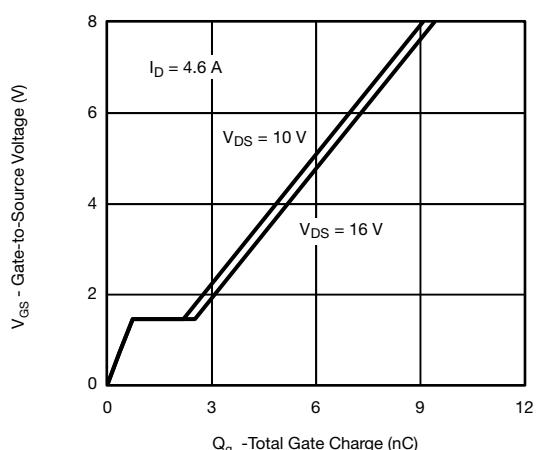
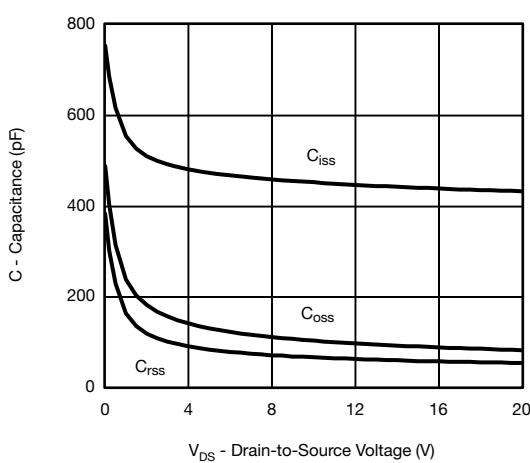
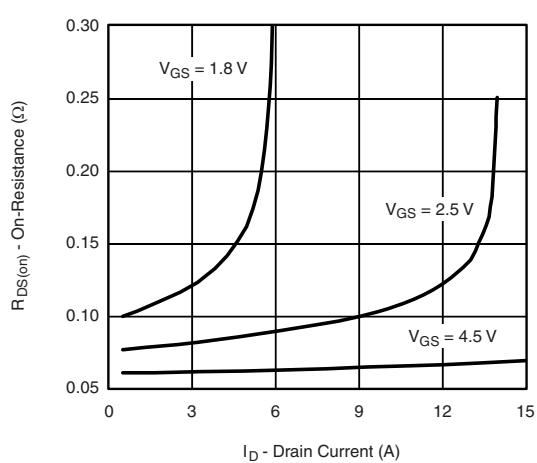
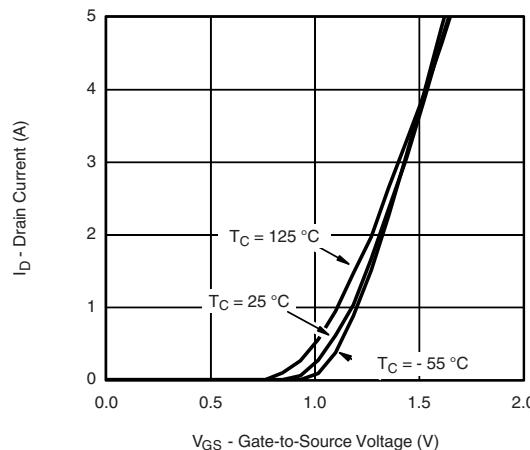
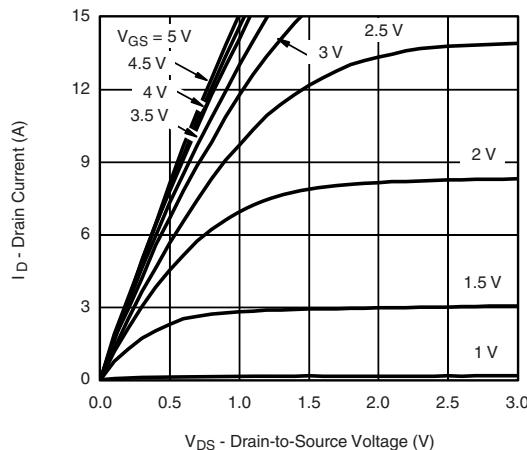
N-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Output Characteristics

Transfer Characteristics

On-Resistance vs. Drain Current and Gate Voltage

Capacitance

Gate Charge

On-Resistance vs. Junction Temperature

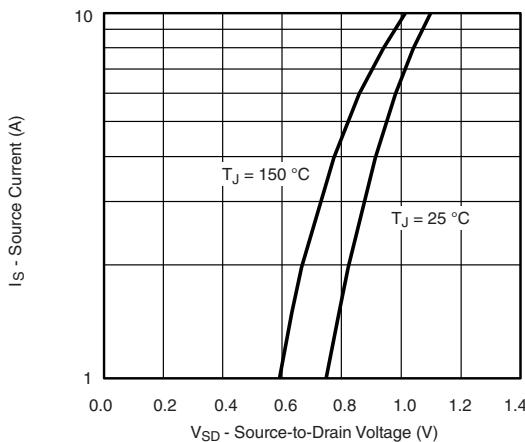
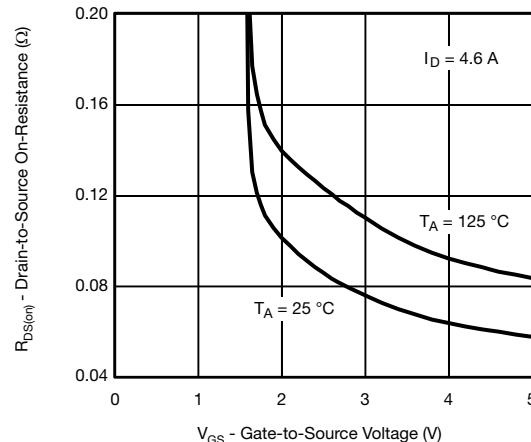
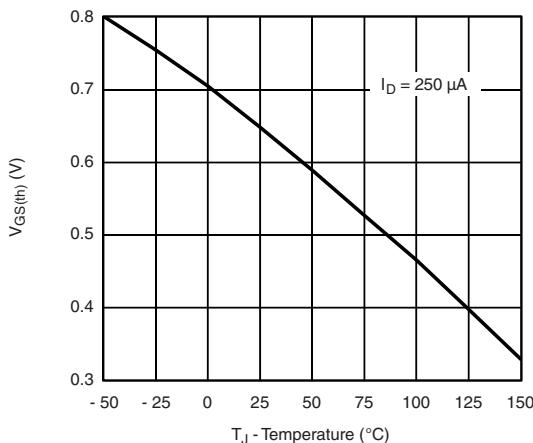
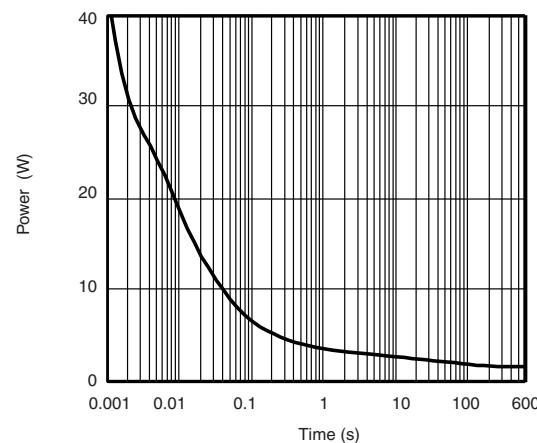
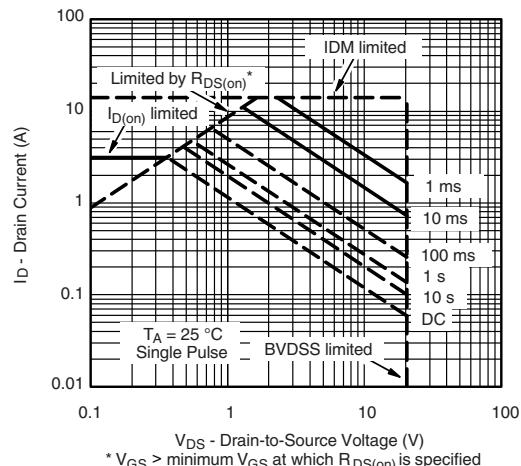
N-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Source-Drain Diode Forward Voltage

On-Resistance vs. Gate-to-Source Voltage

Threshold Voltage

Single Pulse Power, Junction-to-Ambient

Safe Operating Area, Junction-to-Ambient

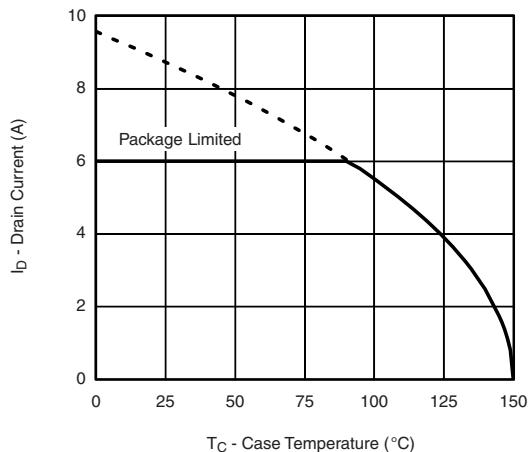
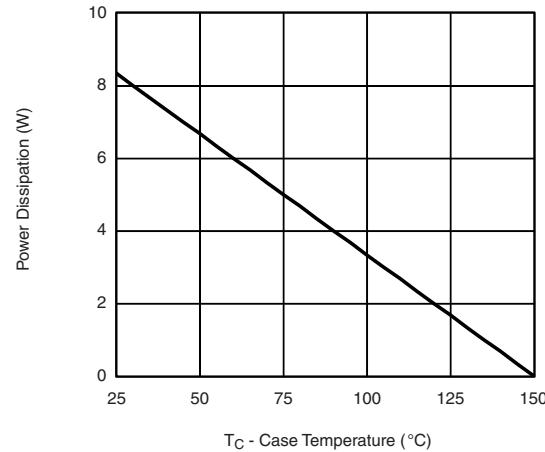
N-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Current Derating ^a

Power Derating
Note

- The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit

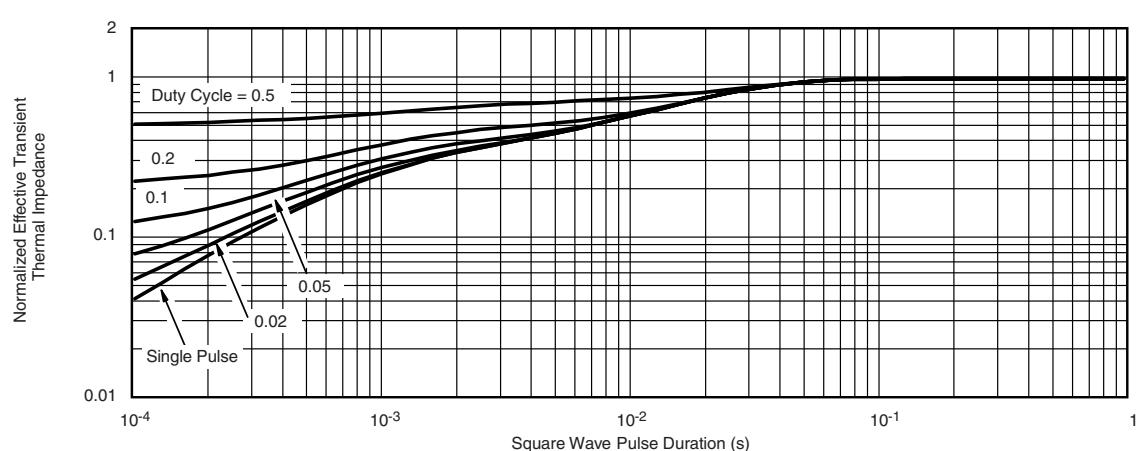
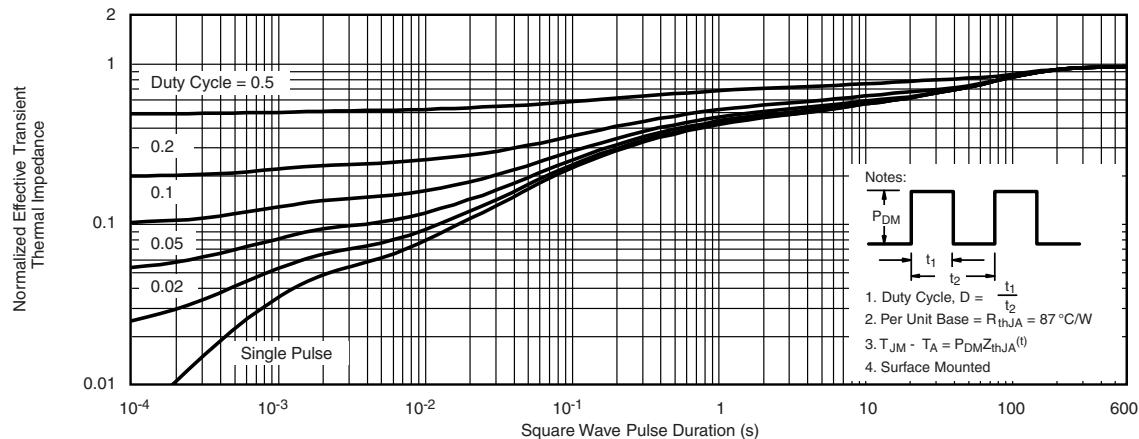
N-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Normalized Thermal Transient Impedance, Junction-to-Ambient

Normalized Thermal Transient Impedance, Junction-to-Case

P-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)


P-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Source-Drain Diode Forward Voltage

On-Resistance vs. Gate-to-Source Voltage

Threshold Voltage

Single Pulse Power, Junction-to-Ambient

Safe Operating Area, Junction-to-Case

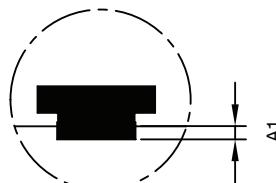
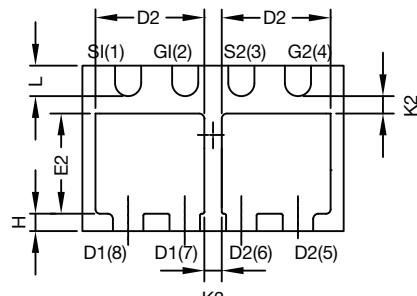
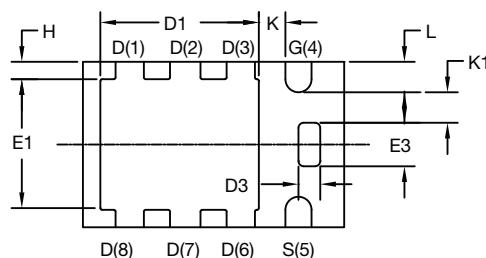
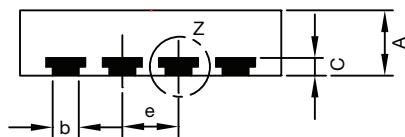
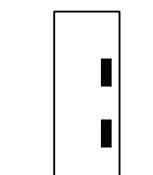
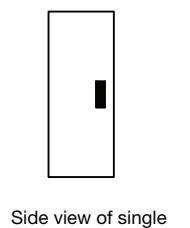
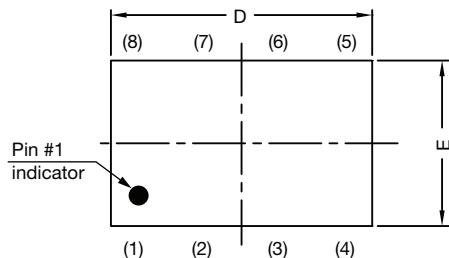
P-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Current Derating ^a

Power Derating
Note

- a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit

P-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)


Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package / tape drawings, part marking, and reliability data, see www.vishay.com/ppg?73529.

PowerPAK® ChipFET® Case Outline



Backside view of single pad

Backside view of dual pad

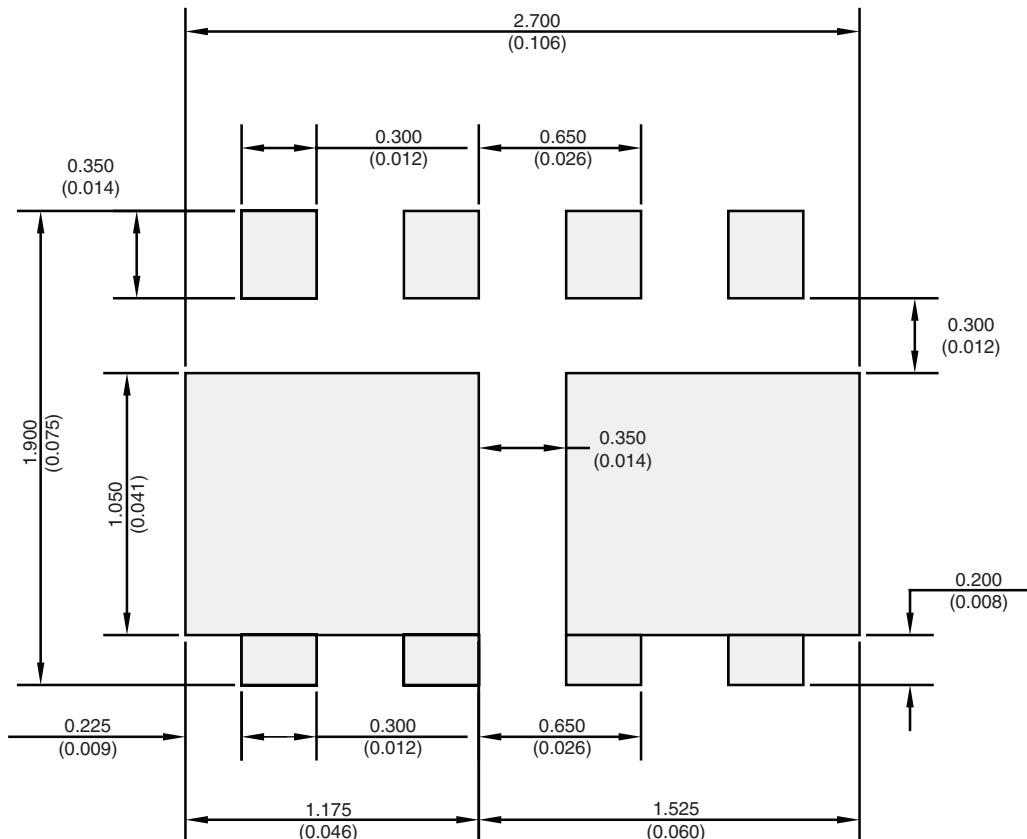
DIM.	MILLIMETERS			INCHES		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
A	0.70	0.75	0.85	0.028	0.030	0.033
A1	0	-	0.05	0	-	0.002
b	0.25	0.30	0.35	0.010	0.012	0.014
C	0.15	0.20	0.25	0.006	0.008	0.010
D	2.92	3.00	3.08	0.115	0.118	0.121
D1	1.75	1.87	2.00	0.069	0.074	0.079
D2	1.07	1.20	1.32	0.042	0.047	0.052
D3	0.20	0.25	0.30	0.008	0.010	0.012
E	1.82	1.90	1.98	0.072	0.075	0.078
E1	1.38	1.50	1.63	0.054	0.059	0.064
E2	0.92	1.05	1.17	0.036	0.041	0.046
E3	0.45	0.50	0.55	0.018	0.020	0.022
e	0.65 BSC			0.026 BSC		
H	0.15	0.20	0.25	0.006	0.008	0.010
K	0.25	-	-	0.010	-	-
K1	0.30	-	-	0.012	-	-
K2	0.20	-	-	0.008	-	-
K3	0.20	-	-	0.008	-	-
L	0.30	0.35	0.40	0.012	0.014	0.016

C14-0630-Rev. E, 21-Jul-14
DWG: 5940

Note

- Millimeters will govern

RECOMMENDED MINIMUM PADS FOR PowerPAK® ChipFET® Dual



Recommended Minimum Pads
Dimensions in mm/(Inches)

Note: This is Flipped Mirror Image
Pin #1 Location is Top Left Corner



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